Notice of References Cited Application/Control No. 10/595,148 Examiner Hai H. Huynh Applicant(s)/Patent Under Reexamination NEISE ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name .	Classification
*	Α	US-6,279,535 B1	08-2001	Matsusaka, Masanobu	123/399
*	В	US-6,505,643 B2	01-2003	Scholten et al.	137/554
*	C	US-6,763,582 B2	07-2004	Kaiser et al.	29/854
*	D	US-6,772,730 B2	08-2004	Kohlen, Peter	123/337
*	ш	US-6,789,526 B2	09-2004	Torii et al.	123/399
*	F	US-6,863,259 B2	03-2005	Torii et al.	251/305
*	G	US-6,886,806 B2	05-2005	Borasch et al.	251/305
*	н	US-6,962,325 B2	11-2005	Torii et al.	251/305
*	_	US-7,159,563 B1	01-2007	Garrick, Robert D.	123/399
*	J	US-2006/0157027 A1	07-2006	Ichikawa et al.	123/399
	K	US-			
	٦	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
	Q			<u>.</u>		
	R					
	s					-
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.